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A New Generation of Variable Temperature Scanning Probe Microscope for Spectroscopy

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In this contribution we present the design and first results of a new generation of variable temperature scanning probe microscope that has been developed to enhance the performance in tunnelling spectroscopy at lower temperatures. Its performance has been proven with imaging and spectroscopy experiments on the well known Si(111), Au(111), and Ag(111) surfaces.

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1. Introduction

Conventional variable temperature scanning probe microscopes (SPMs) became available about 20 years ago. The main idea was to look at structures at lower temperatures (≈ 50 K) where the thermal mobility is reduced and imaging of structures (i.e. molecules on a surface) was easier to achieve. Conventional variable temperature SPM microscopes [1–3] always cool the sample only. The rest of the instrument, including the scanner with the tunnelling tip, stays at room temperature. This design has a lot of advantages with respect to flexibility and an open design. However, the sample is always faced a warm tip and the instrument needs a careful design to minimize thermal drift. With this design approach it has been possible to reduce the remaining thermal drift to values lower than 50 pm/s [1]. Imaging surfaces at low temperatures deliver good results, however this setup is not ideal for spectroscopy measurements due to the remaining drift between the tip and the surface. In conventional variable temperature designs it is therefore required to perform spectroscopy experiments quickly.

In the last decade tunnelling spectroscopy has received more and more importance in surface science. In addition to imaging a surface or a surface with molecular structures, tunnelling spectroscopy is required to learn more about these new structures and their interaction with the surface or the environment. Due to the lack of spectroscopy performance of conventional variable temperature designs, research moved to low temperature scanning tunneling microscopy (STM) designs where the complete STM is kept at a low temperature (4 K or 77 K) by using bath cryostats. However, these instruments often require a system solution due to their complex design with shielded nitrogen and helium tanks [4, 5]. An alternative and a next generation is a compact variable temperature SPM with a cold tip. This needs a new approach, the design of a new and compact SPM stage, optimized thermal shields, a dedicated heat flow control and a stable and precise temperature regulation.

2. Experimental

The new SPM is based on a novel design which uses a new flow cryostat compatible for cooling with liquid nitrogen or helium. In contrast to earlier established designs of variable temperature SPM, where only the sample is cooled, this new SPM also cools the scanner and tip. This is realised by a newly developed compact and stable SPM stage with thermal shields and a dedicated cooling management system. With this design we achieve lower temperatures and improve drift by more than an order of magnitude compared to previous variable temperature stages. Sample temperatures down to 10 K (with helium) and 95 K (with nitrogen) have been achieved. The temperature stability is better than 5 mK/min and the measured thermal drift is below 1 pm/s. During cooling the mechanical z stability is better than 3 pm. These conditions offer enhanced spectroscopy measurement capability with a cold tip. "Loop off" times of up to 10 s per single spectroscopy curve have been measured. The new flow cryostat also allows for changing between nitrogen cooling and helium cooling in less than 90 min during a running experiment. Pre-cooling with nitrogen during the starting phase of an experiment also reduces running costs for liquid helium. This new SPM is configured for imaging in STM as well as AFM with a non-optical sensor $% \left({{{\mathbf{T}}_{\mathrm{S}}}^{\mathrm{T}}} \right)$ in a temperature range between 15 and 400 K. Switching between the 2 modes can be accomplished without breaking vacuum.

3. Results

The Fermi SPM was tested at full cooling power using the flow cryostat with liquid helium. First experiments were done on the well known Si(111) 7×7 reconstruction

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(Fig. 1) at 10 K. The image shows clear atomic resolution of the topography with characteristic rosettes and missing atoms (left), and a line profile (right). This image corresponds well to examples presented in literature [6-8].



Fig. 1. Si(111) 7×7 reconstruction, 20 nm \times 20 nm, $U_{\text{gap}} = 1.4$ V, $I_{\text{t}} = 1.5$ nA, sample stage at 10 K, tip/ scanner at 25 K (a), line profile (b).



Fig. 2. Au(111) topography 10 nm × 6 nm, $U_{\rm gap} = -0.5$ V, $I_{\rm t} = 2$ nA, sample stage at 10 K, tip/scanner at 25 K, unfiltered raw data (a), line profile proving z stability (b).

Similarly, an Au(111) surface was imaged at 10 K. Figure 2 shows topography with atomic resolution. Unfiltered raw data is presented. The line profile is a proof for the high resolution capability under these conditions. Au corrugation is in the range of 5 pm and corresponds well with the literature data [9]. We estimate the z stability of only a few pm with full cooling power. Low thermal drift has been also confirmed by spectroscopy experiments.

The performance for tunnelling spectroscopy was tested on Au(111) surface at a sample temperature of 10 K (Fig. 3). Having tip and sample cold results in a low thermal z drift and also piezo creeping effects are reduced with the cold scanner. After positioning of the tip on the surface in regulated mode the feedback loop was switched off. The gap voltage was ramped from -0.2 V to 0.8 V and back to -0.2 V. The total time for a single measurement was 10 s. Both I(V) and dI/dVcharacteristics were measured simultaneously. The I(V)characteristic for ramp up and ramp down only shows a small offset. The drift in z direction is estimated in below 1 pm/s. Also seen in the dI/dV spectrum (blue) is the



Fig. 3. Point spectroscopy characteristic on the Au(111). Voltage ramped from -0.2 V to 0.8 V to -0.2 V. Feedback loop switched off for 10 s (a), simultaneously recorded dI/dV characteristic showing the surface state on Au(111) (b).



Fig. 4. Electron standing waves on the Ag(111), scan range: 100 nm \times 100 nm, $U_{gap} = 5$ mV, $I_t = 2$ nA, sample stage at 10 K, tip/scanner at 25 K.

onset of the surface states on the Au(111) surface which agrees with the value in literature [10].

Standing electron waves have been observed on Ag(111) surface at 10 K (Fig. 4). The Ag(111) surface has a surface state around -65 mV which forms a two-dimensional nearly free electron gas parallel to the surface and many physical phenomena may be observed [11–13]. The surface state of Ag(111) can be directly measured using dI/dV spectroscopy. These sur-



Fig. 5. Point spectroscopy characteristic, voltage ramped from -1 V to 1 V to -1 V. I(V) characteristics show onset of the surface state at approximately -70 mV (a), simultaneously measured dI/dVsignal (b).

face state electrons scatter from defects and step edges on Ag(111) and produce interference patterns known as electron standing waves [14]. The electron standing waves can be directly observed even in normal STM images when acquired at lower biases close to the Fermi energy on Ag(111). The characteristics of I/V and dI/dV spectroscopy are shown in Fig. 5.

4. Summary

We successfully realised a new generation of variable temperature SPM with a cold tip. The "Fermi SPM" uses a flow cryostat that can be operated with liquid helium or liquid nitrogen. Sample and scanner are individually connected to the cryostat cold finger using flexible cooling connections. Sample and scanner temperature are individually regulated. Sample temperature of 10 K has been achieved with helium cooling, and 95 K with nitrogen cooling. Z stability is better than 3 pm during cooling. Thermal drift is below 1 pm/s. Temperature stability is better than 5 mK/min. The device may be operated in the temperature range 10–400 K. The microscope performance has been proven with well known Si(111), Au(111), and Ag(111) surfaces.

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